-

Notic of References Cited

| Application/Control No. | Applicant(s)/Pate | nt Under | |
|-------------------------|-------------------------------------|-------------|---|
| 09/901,597 | Reexamination NISHIYAMA ET A | AL. | |
| Examiner | Art Unit | | _ |
| EDMUND H LEE | 1732 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|------|----------------|
| | Α | US- | | | |
| | В | US- | | | |
| | С | US- | | | |
| | D | US- | | | |
| | Ε | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | _ | US- | | | |
| | J | US- | | | |
| | к | US- | | | |
| | L | US- | | | |
| | М | US- | - | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | JP 09239807A | 09-1997 | JP | | |
| | 0 | JP 56044643A | 04-1991 | JP | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| $\overline{}$ | T - | TOTAL POSSILENTS |
|---------------|----------|---|
| * | <u> </u> | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.